

<b>Notice of References Cited</b>	Application/Control No. 10/751,731	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Thomas D. Alunkal	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,732,062	03-1998	Yokoi et al.	369/116
*	B	US-6,343,062	01-2002	Furukawa et al.	369/275.4
*	C	US-5,608,710	03-1997	Minemura et al.	369/47.51
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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